

Notice of References Cited

Application/Control No.

10/660,110

Applicant(s)/Patent Under
Reexamination
OLDHAM ET AL.

Examiner

Russell S. Negin

Art Unit

1631

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	V	Kobayashi et al. Photodiode array detection in high-performance capillary electrophoresis. Journal of Chromatography, volume 480, 1989, pages 179-184.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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